

# SILICON POWER TRANSISTOR 2SC4551

# NPN SILICON EPITAXIAL TRANSISTOR FOR HIGH-SPEED SWITCHING

The 2SC4551 is a power transistor developed for high-speed switching and features low  $V_{\text{CE(sat)}}$  and high here. This transistor is ideal for use in drivers such as DC/DC converters and actuators.

In addition, a small resin-molded insulation type package contributes to high-density mounting and reduction of mounting cost.

#### **FEATURES**

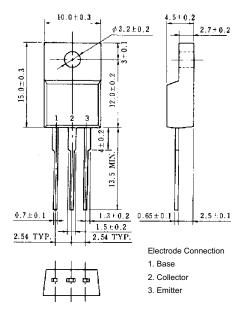
- High hre and low VcE(sat):  $hre \geq 100 \; (VcE=2 \; V, \; Ic=2 \; A)$   $VcE(sat) \leq 0.3 \; V \; (Ic=6 \; A, \; IB=0.3 \; A)$
- Mold package that does not require an insulating board or insulation bushing

#### ABSOLUTE MAXIMUM RATINGS (Ta = 25°C)

Parameter	Symbol	Ratings	Unit
Collector to base voltage	V <sub>СВО</sub>	100	V
Collector to emitter voltage	Vceo	60	V
Emitter to base voltage	V <sub>EBO</sub>	7.0	V
Collector current (DC)	I <sub>C(DC)</sub>	10	Α
Collector current (pulse)	Ic(pulse)*	20	Α
Base current (DC)	I <sub>B(DC)</sub>	5.0	Α
Total power dissipation	P <sub>T</sub> (Tc = 25°C)	30	W
Total power dissipation	P⊤ (Ta = 25°C)	2.0	W
Junction temperature	Tj	150	°C
Storage temperature	T <sub>stg</sub>	-55 to +150	°C

<sup>\*</sup> PW  $\leq$  300  $\mu$ s, duty cycle  $\leq$  10%

#### PACKAGE DRAWING (UNIT: mm)



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# **ELECTRICAL CHARACTERISTICS (Ta = 25°C)**

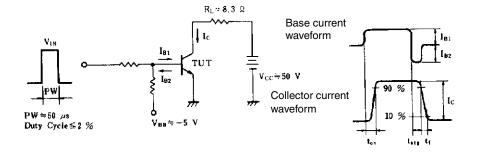
Parameter	Symbol	Conditions	MIN.	TYP.	MAX.	Unit
Collector to emitter voltage	VCEO(SUS)	Ic = 6.0 A, I <sub>B</sub> = 0.6 A, L = 1 mH	60			٧
Collector to emitter voltage	VCEX(SUS)	$I_C = 6.0 \text{ A}, I_{B1} = -I_{B2} = 0.6 \text{ A},$ 60 $V_{BE(OFF)} = -1.5 \text{ V}, L = 180 \ \mu\text{H}, clamped$				V
Collector cutoff current	Ісво	V <sub>CB</sub> = 60 V, I <sub>E</sub> = 0			10	μΑ
Collector cutoff current	ICER	$V_{CE} = 60 \text{ V}, \text{ R}_{BE} = 50 \Omega, \text{ Ta} = 125^{\circ}\text{C}$			1.0	mA
Collector cutoff current	ICEX1	$V_{CE} = 60 \text{ V}, V_{BE(OFF)} = -1.5 \text{ V}$			10	μΑ
Collector cutoff current	ICEX2	Vce = 60 V, Vbe(off) = -1.5 V, Ta = 125°C			1.0	mA
Emitter cutoff current	ІЕВО	V <sub>EB</sub> = 5.0 V, I <sub>C</sub> = 0			10	μΑ
DC current gain	h <sub>FE1</sub> *	Vce = 2.0 V, Ic = 1.0 A	100			
DC current gain	h <sub>FE2</sub> *	Vce = 2.0 V, Ic = 2.0 A	100	200	400	
DC current gain	h <sub>FE3</sub> *	Vce = 2.0 V, Ic = 6.0 A	60			
Collector saturation voltage	V <sub>CE(sat)1</sub> *	Ic = 6.0 A, I <sub>B</sub> = 0.3 A			0.3	V
Collector saturation voltage	VCE(sat)2*	Ic = 8.0 A, I <sub>B</sub> = 0.4 A			0.5	٧
Base saturation voltage	V <sub>BE(sat)1</sub> *	Ic = 6.0 A, I <sub>B</sub> = 0.3 A			1.2	V
Base saturation voltage	V <sub>BE(sat)2</sub> *	Ic = 8.0 A, I <sub>B</sub> = 0.4 A			1.5	V
Collector capacitance	Cob	V <sub>CB</sub> = 10 V, I <sub>E</sub> = 0, f = 1.0 MHz		150		pF
Gain bandwidth product	f⊤	VcE = 10 V, lc = 1.0 A		140		MHz
Turn-on time	ton	$I_{C} = 6.0 \text{ A}, R_{L} = 8.3 \Omega,$			0.3	μs
Storage time	tstg	$I_{B1} = -I_{B2} = 0.3 \text{ A}, \text{ Vcc} \cong 50 \text{ V}$ Refer to the test circuit.			1.5	μs
Fall time	tf	neler to the test circuit.			0.3	μs

<sup>\*</sup> Pulse test PW  $\leq$  350  $\mu$ s, duty cycle  $\leq$  2%

### **hfe CLASSIFICATION**

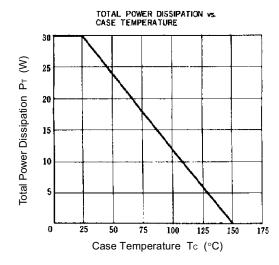
Marking	М	L	К
h <sub>FE2</sub>	100 to 200	150 to 300	200 to 400

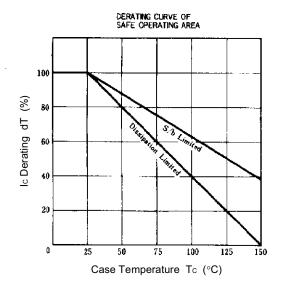
# SWITCHING TIME (ton, tstg, tf) TEST CIRCUIT

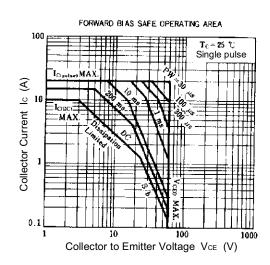


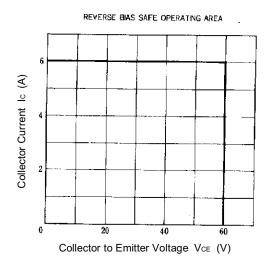


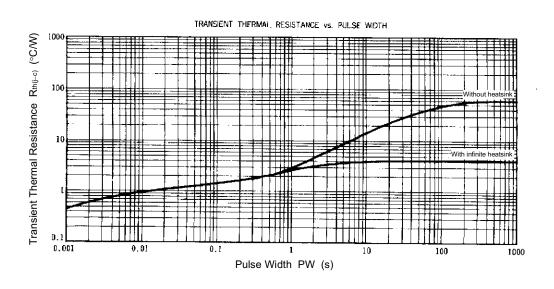
# TYPICAL CHARACTERISTICS (Ta = 25°C)



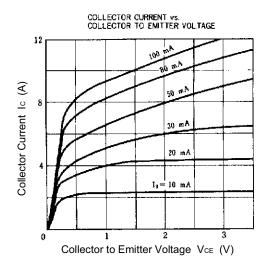


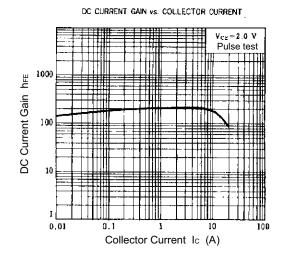


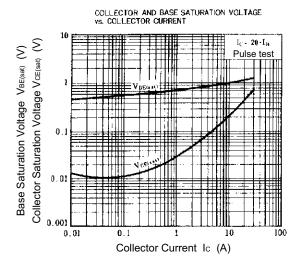


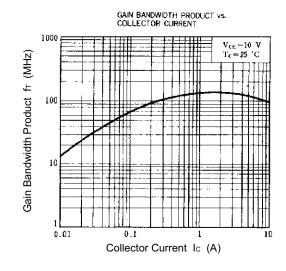


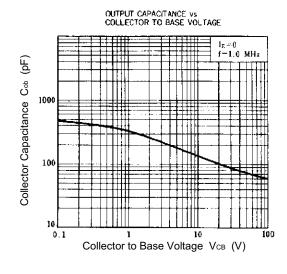
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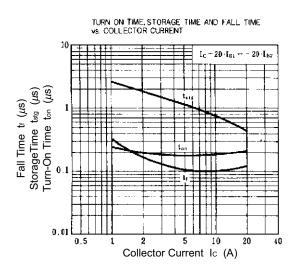














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